Notice of References Cited Application/Control No. 10/705,899 Examiner HOAN C. NGUYEN Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,680,769 B1	01-2004	Lee et al.	349/129
*	В	US-6,356,335 B1	03-2002	Kim et al.	349/156
*	C	US-6,504,592 B1	01-2003	Takatori et al.	349/129
*	D	US-5,710,609 A	01-1998	Shimada, Shinji	349/126
	Е	US-		•	
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	J	US-		, , , , , , , , , , , , , , , , , , ,	
	K	US-			
	L	US-			
= #5	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q				•	
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	
	V	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.